

<b>Notice of References Cited</b>	Application/Control No. 09/222,340	Applicant(s)/Patent Under Reexamination TERRELL ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,009,475	12-1999	Shrader, Theodore Jack London	709/249
	B	US-6,408,336	06-2002	Schneider et al.	709/229
	C	US-6,484,261	11-2002	Wiegel, Scott L.	713/201
	D	US-6,504,819	01-2003	Fowler et al.	370/230
	E	US-6,850,528	02-2005	Crocker et al.	370/401
	F	US-5,881,315	03-1999	Cohen, Richard Jay	710/52
	G	US-6,031,841	02-2000	Woundy, Richard	370/410
	H	US-5,983,270	11-1999	Abraham et al.	709/224
	I	US-6,714,517	03-2004	Fawaz et al.	370/236
	J	US-5,623,601	04-1997	Vu, Hung T.	713/201
	K	US-5,321,837	06-1994	Daniel et al.	707/4
	L	US-6,581,093	06-2003	Verma, Dinesh Chandra	709/220
	M	US-6,269,382	07-2001	Cabrera et al.	707/204

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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